

Optional Collimation Fixture

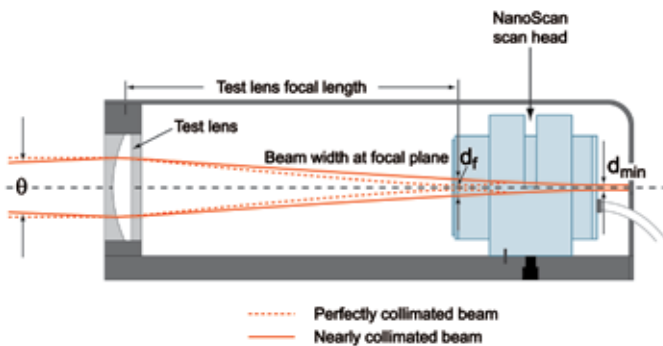
Collimation is one of the most common applications for which the NanoScan2 is used. The Collimation Fixture provides an easy and extremely accurate method for making this adjustment to a laser system.

The Collimation Fixture comprises a test lens with the NanoScan2 profiler positioned to measure the beam size at the geometric focus of the lens. From lens theory, the angle of collimation is determined by the equation:

$$\theta = Df / f,$$

where θ is the angle of collimation, Df is the beam size measured at the lens focal length, and f is the focal length of the lens. Once the beam size is measured at the focal length of the lens, simply dividing this measured beam size by the focal length determines the laser beam collimation angle. Practically speaking, adjusting the optics to generate the smallest Df , will result in the minimum divergence angle. The beam profiler remains fixed, and active alignment is easily performed in real time. This level of simplicity, speed, and functionality is simply not possible with techniques involving multiple beam profile positions.

Divergence/Collimation test fixtures based on a high quality test lens to focus your collimated or diverging beam. Fixtures require a complete NanoScan System. Wavelength of use should be specified at time of order.



COL-FXT 250	Nominal 250mm focal length lens. Includes an enclosure to block stray light
COL-FXT 500	Nominal 500mm focal length lens. Includes an enclosure to block stray light
COL-FXT 250 TEL	Nominal 250mm focal length lens. For wavelengths of use at 1310 or 1550nm with lens repositioning. Includes an enclosure to block stray light
COL-FXT C02	Zinc selenide (ZnSe) lens with a focal length of 190.5mm. For wavelength of use at 10.6um. Includes an enclosure that holds an adjustable entrance iris. Requires a Pyro NanoScan System

M² Wizard

M-squared (M²) software Wizard is an interactive program for determining the “times diffraction limit” factor M² by the Rayleigh Method. The M² Wizard prompts and guides the user through a series of manual measurements and data entries required for calculating M².

The Optional Rayleigh Range Translation Test Fixture (RAL-FXT) provides convenient translation of a NanoScan scanhead assembly and a digital readout of its relative position along the Z-axis. Used with a user-provided focusing lens and the M² Wizard in the NanoScan Analysis Software, this fixture offers a quick and easy method to determine the times-diffraction propagation factor (M²) of a laser.

The RAL-FXT features a base plate, sliding carriage and digital micrometer. The base plate (5.4×10.2×0.38in.) provides a series of ¼-20 threaded mounting holes at 2in. centers to facilitate convenient fixturing of the assembly with respect to the focusing lens. The sliding carriage accommodates the combination of the 0.125-in. dowel pin and the ¼-20 mounting hole found on any Photon scan head’s rotation mount, and enables smooth movement of the scan head assembly over a 6-in. range of travel. A Mitutoyo micrometer with a handy re-zeroing feature and accompanying slide provides precise determination of the scan head location and/or travel distance with a resolution of tens of microns. For automated and automatic M² measurements the NanoModeScan option is required.



The optional Translation Test Fixture makes manual M² measurements accurate and repeatable

Pulsed Laser Beam Profiling

In addition to profiling CW laser beams, NanoScan can also profile pulsed laser beams with repetition rate in the 10kHz range and above. To enable the measurement of these pulsed lasers, the NanoScan profiler incorporates a “peak connect” algorithm and software-controlled variable scan speed on all scanheads. The accuracy of the measurement generally depends on the laser beam spot size and the pulse-to-pulse repeatability of the laser. The NanoScan is ideal for measuring Q-switched lasers and lasers operating with pulse width modulation power (PWM) control. In the past few years, lasers with pico- and femtosecond pulse durations have begun to be used in many applications. Although these lasers add some additional complication to the measurement techniques, the NanoScan can also measure this class of laser.

Optional Automation Interface

For customer who want to incorporate the NanoScan2 into an automated procedure or to create a customized user interface, the PRO version scanheads include an ActiveX Automation Server that can be used by an Automation Client written in Visual Basic for Applications (VBA), C/ C++ or by an application which supports ActiveX Automation, such as Microsoft Excel, Microsoft Word or National Instruments’ LabVIEW. The software package include example of programs written in Excel and LabVIEW in the automation folder.

Measured Beam Results

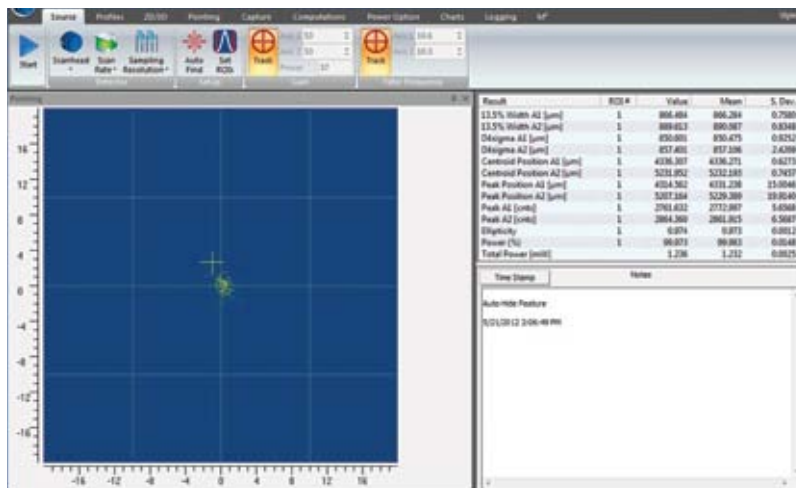
From 1989 through 1996, John Fleischer, founder and past President of Photon Inc., chaired the working laser beam width ISO/DIN committee that resulted in the ISO/DIN 11146 standard. The final approved standard, available in 13 languages. The standard governs profile measurements and analysis using scanning apertures, variable apertures, area sensors and detector arrays. NanoScan 2 measures spatial beam irradiance profiles using scanning slit techniques.

Results measured include:

- Beam Width at standard and user-definable clip levels, including $1/e^2$ and 4σ
- Centroid Position
- Peak Position
- Ellipticity
- Gaussian Fit
- Beam Divergence
- Beam Separation
- Pointing Stability
- ROI Power
- Total Power
- Pulsed Laser Repetition Rate

Result	ROI #	Value	Mean	S. Dev.
13.5% Width A1 [μm]	1	863.328	864.612	0.7082
13.5% Width A2 [μm]	1	876.317	875.622	0.9432
D4sigma A1 [μm]	1	849.062	849.700	1.5084
D4sigma A2 [μm]	1	842.054	840.924	2.3751
Centroid Position A1 [μm]	1	1.111	-0.133	0.5622
Centroid Position A2 [μm]	1	-1.730	0.275	1.2221
Peak Position A1 [μm]	1	-11.521	-19.890	5.6014
Peak Position A2 [μm]	1	4.156	8.732	6.9860
Peak A1 [cnts]	1	2812.438	2810.688	4.0486
Peak A2 [cnts]	1	2687.898	2678.320	5.5879
Ellipticity	1	0.806	0.807	0.0023
Power [%]	1	99.994	99.979	0.0273
Total Power [mW]		1.202	1.203	0.0002

Example of the many measurements that can be made and the precision you can expect



Knowing pointing stability is a critical factor in laser performance

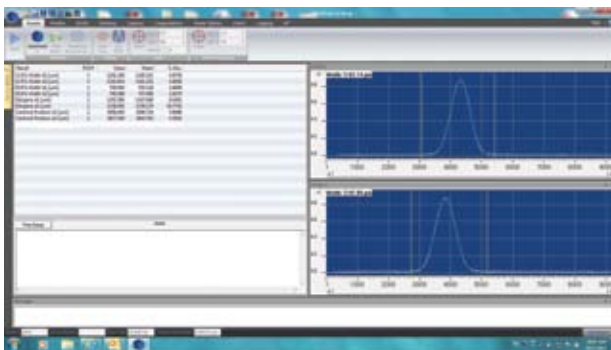
The Most Versatile and Flexible Beam Profiling System Available

With the available range of detectors, slit sizes and apertures the NanoScan 2 provides the maximum versatility in laser beam profiling. NanoScan 2 adds the convenience and portability of direct USB connectivity: no external controllers or power supplies required to operate the profiler. In addition the rotation mount has been redesigned to provide a stand for vertical operation, if desired. The mount can be positioned in one of two places. If vertical operation is desired the mount is positioned toward the back of the scanhead to expose the stand, which can be affixed to the optical table or stage. If standard horizontal operation is desired, then the rotation mount can be positioned in the forward configuration, maintaining the original length and size of the scanhead.

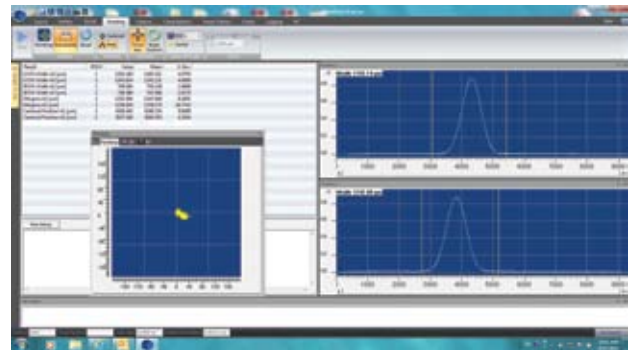


See Your Beam As Never Before

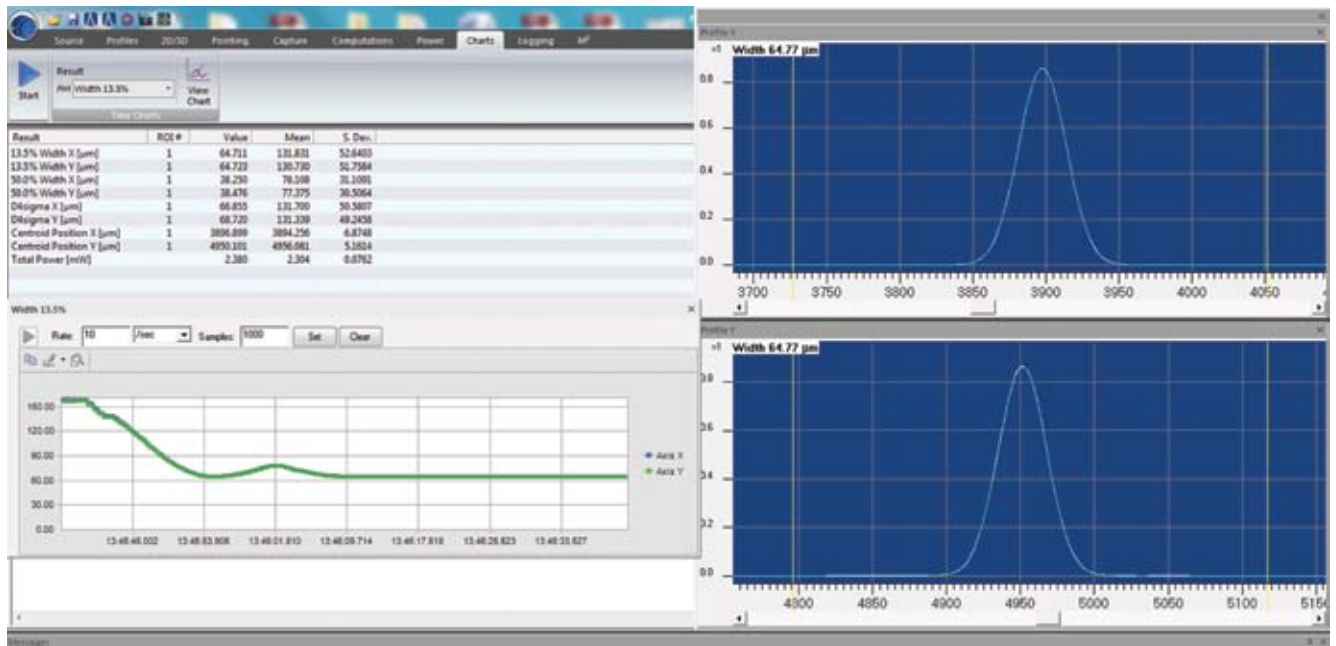
The new NanoScan2 graphical user interface (GUI) allows the user to set the display screens to any appropriate configuration, displaying those that are of interest and hiding what is not. This means that you can have the information that you want to see, uncluttered by extraneous output, and you can have all the features you need, visible at once. The screens can be docked or floating with ribbon bars for the controls that can be visible or hidden as desired. This allows you to take advantage of a large, multi-monitor desk top or maximize the useful information on a small laptop display.



Simple docked view of profiles and numerical results



Both docked and undocked windows: profiles, results, and pointing



Example of time charts used to monitor focusing process

NanoScan 2 Scanhead Model	Ge/3.5/1.8 μ m	Ge/9/5 μ m	Ge/9/25 μ m
Wavelength	700nm - 1800nm	700nm - 1800nm	700nm - 1800nm
Slit Size	1.8 μ m	5 μ m	25 μ m
Aperture Size	3.5mm	9mm	9mm
1/e ² Beam Diameter Range	7 μ m~2.3mm	20 μ m~6mm	100 μ m~6mm
Spatial Sampling Resolution	5.3nm – 18.3 μ m		
Profile Digitization	16 bit		
Scan Frequency	1.25, 2.5, 5, 10, 20Hz		
Power Reading	User calibrated		
Power Aperture Window	Metalized Quartz (200mW upper limit)		
Laser Type	CW or Pulsed		
Operating Range	See Operating Space Chart		
Damage Threshold	See Operating Space Chart		
Rotation Mount	Standard		
Scanhead Dimension	63.4mm diameter x102.6mm long See Mechanical Drawing for details		

NanoScan2 Scanhead Model	Pyro/9/5 μ m	Pyro/9/25 μ m
Wavelength	190nm->100 μ m	190nm->100 μ m
Slit Size	5 μ m	25 μ m
Aperture Size	9mm	9mm
1/e ² Beam Diameter Range	20 μ m~6mm	100 μ m~6mm
Spatial Sampling Resolution	5.3nm-18.3 μ m	
Profile Digitization	16-bit	
Scan Frequency	1.25, 2.5, 5, 10, 20Hz	
Power Reading	Not Available	
Power Aperture Window	N A	
Laser Type	CW or Pulsed	
Operating Range	See Operating Space Chart	
Damage Threshold	See Operating Space Chart	
Rotation Mount	Standard	
Scanhead Dimension	63.4mm diameter x102.6mm long See Mechanical Drawing for details	

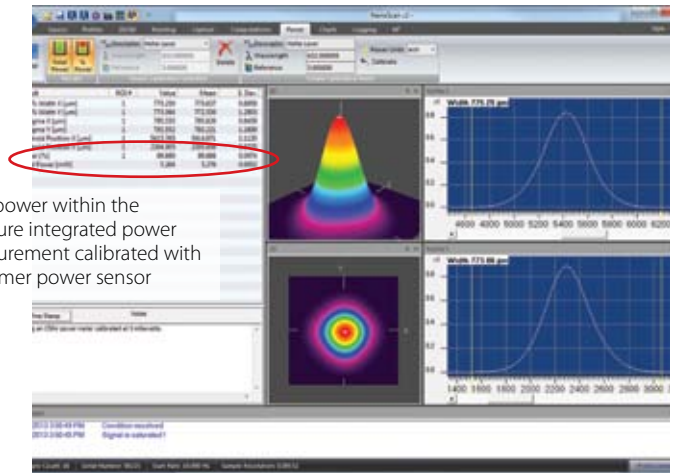
Integrated Power Meter

The silicon and germanium detector equipped NanoScan 2 systems include an integrated 200mW power meter. The scanhead comes with a quartz attenuator window that provides a uniform response across a broad wavelength range.

This is a relative power meter that has better than 1.5% correspondence when calibrated with a user-supplied power meter and used in the same configuration as calibrated.

The power meter screen in the software shows both the total power and the individual power in each of the beams being measured.

% of power within the aperture integrated power measurement calibrated with customer power sensor



Available Detectors

The NanoScan 2 is available with silicon, germanium or pyroelectric detectors to cover the light spectrum from UV to very far infrared.

Apertures and Slits

The NanoScan 2 is available with a variety of apertures and slit sizes to allow for the accurate measurement of varying beam sizes. The slit width defines the minimum beam width that can be measured; due to convolution error, the slit should be no larger than $\frac{1}{4}$ the beam diameter to provide a $\pm 3\%$ accurate measurement. For this reason the minimum beam diameter measurable with the standard $5\mu\text{m}$ slit is $20\mu\text{m}$. To measure beams smaller than $20\mu\text{m}$ it is necessary to use the small aperture $1.8\mu\text{m}$ slit instrument, providing a minimum beam diameter of $\sim 8\mu\text{m}$. Because these slits are so narrow, the maximum length limits the aperture to 3.5mm. Contrary to many people's beliefs, these smaller slits do not improve the resolution of the measurement, only the minimum size of the beam. Therefore, unless it is necessary to measure beams less than $20\mu\text{m}$, one would be advised to stick with the $9\text{mm}/5\mu\text{m}$ configurations.

For very large beams, NanoScan is available with a large 20 or 25mm aperture with $25\mu\text{m}$ slits. These sensor are larger than the standard scan heads (100mm diameter)

NanoScan 2 Scanhead Model	Si/3.5/1.8 μm	Si/9/5 μm	Si/9/25 μm
Wavelength	190nm - 950nm	190nm - 950nm	190nm - 950nm
Slit Size	1.8 μm	5 μm	25 μm
Aperture Size	3.5mm	9mm	9mm
1/e ² Beam Diameter Range	7 μm ~2.3mm	20 μm ~6mm	100 μm ~6mm
Spatial Sampling Resolution		5.3nm-18.3 μm	
Profile Digitization		16-bit	
Scan frequency		1.25, 2.5, 5, 10, 20Hz	
Power Reading		User calibrated	
Power Aperture Window		Metalized Quartz (200mW upper limit)	
Laser Type		CW or Pulsed	
Operating Range		See Operating Space Charts	
Damage threshold		See Operating Space Charts	
Rotation Mount		Standard	
Scanhead Dimension		63.4mm diameter x102.6mm long See Mechanical Drawing for details	

NanoScan 2 Configurable User Interface

In addition to new hardware, the NanoScan2 has an updated integrated software package for the Microsoft Windows Platform, which allows the user to display any of the results windows on one screen. The NanoScan 2 software comes in two versions, STD and PRO. The NanoScan2 Pro version includes ActiveX automation for users who want to integrate the NanoScan into OEM systems or create their own user interface screens with C++, LabView, Excel or other OEM software packages.

The screenshot shows the NanoScan 2 software interface with the following components labeled:

- File Menu**: Located at the top left corner.
- Quick Access Toolbar**: Located below the File Menu, containing icons for Start, Scanhead, Scan Rate, Sampling Resolution, Auto Find, Set ROIs, Track, and Filter Frequency.
- Ribbon Tabs**: Located below the Quick Access Toolbar, including Source, Profiles, 2D/3D, Pointing, Capture, Computations, Power Option, Charts, Logging, and M.
- Panel**: The area containing the various tool icons.
- Title Bar**: The top bar of the window, labeled "NanoScan2".
- Ribbon Bar**: The bar containing the ribbon tabs.
- Standard Windows Controls**: The minimize, maximize, and close buttons in the top right corner.
- Results Window**: A table displaying measurement data.
- User Notes**: A text area for entering notes.
- Status Bar**: The bottom bar showing system parameters.
- Primary Dock Window (note tabs)**: A graph showing a beam profile with a width of 868.57 μm.

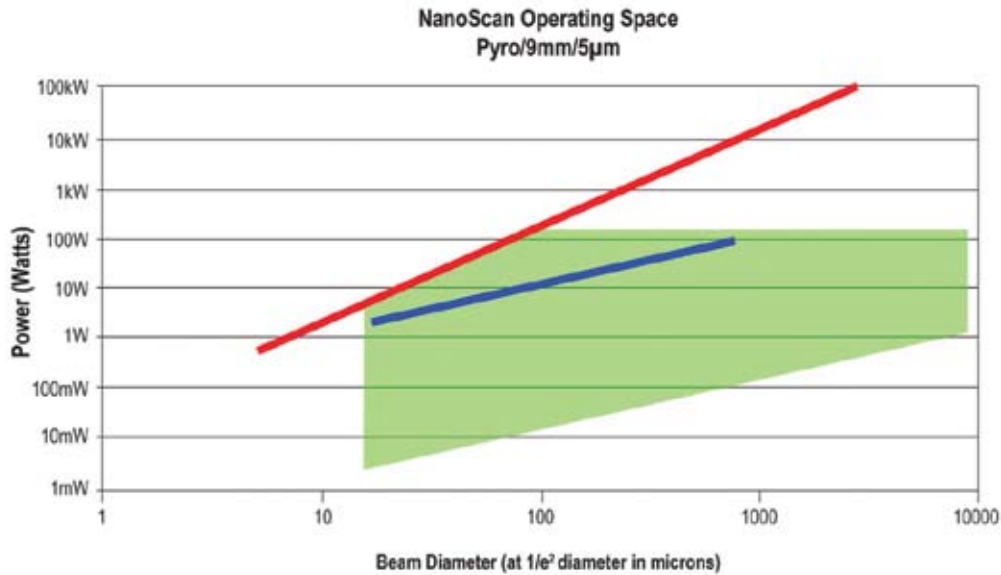
Result	ROI #	Value	Mean	S. Dev.
13.5% Width A1 [μm]	1	809.185	868.044	0.6725
13.5% Width A2 [μm]	1	891.686	892.911	0.8152
D4sigma A1 [μm]	1	850.980	850.778	0.7756
D4sigma A2 [μm]	1	861.653	858.824	2.4237
Centroid Position A1 [μm]	1	4336.223	4336.540	0.6342
Centroid Position A2 [μm]	1	5232.240	5232.276	0.7477
Peak Position A1 [μm]	1	4353.641	4337.945	19.0861
Peak Position A2 [μm]	1	5213.662	5225.928	12.8667
Peak A1 [cnts]	1	2757.306	2755.409	3.6923
Peak A2 [cnts]	1	2834.674	2586.838	119.0562
Ellipticity	1	0.975	0.972	0.0013
Power (%)	1	99.969	99.987	0.0130
Total Power [mW]	1	1.231	1.227	0.0033

3.3.1 Beam Analysis

Example of display configuration window

NanoScan Options and Accessories

Item	Description	P/N
NS2-Si/3.5/1.8-STD	NanoScan2 Silicon Detector 3.5mm aperture 1.8µm slits. High-resolution head featuring Silicon detector, 63.5mm diameter head with rotation mount, 3.5mm entrance aperture, and matched pair of 1.8µm wide slits. Use from 190nm to wavelengths <1µm. Not for 1.06µm wavelength.	PH00421
NS2-Si/9/5-STD	NanoScan2 Si Detector 9mm aperture 5µm slits. High-resolution head featuring Si detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 190nm to wavelengths <1µm. Not for 1.06µm wavelength.	PH00422
NS2-Si/9/25-STD	NanoScan2 Si Detector 9mm aperture 25µm slits. High-resolution head featuring Si detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 25µm wide slits. Use from 190nm to wavelengths <1µm. Not for 1.06µm wavelength.	PH00423
NS2-Ge/3.5/1.8-STD	NanoScan2 Ge Detector 3.5mm aperture 1.8µm slits. High-resolution head featuring Germanium detector, 63.5mm diameter head with rotation mount, 3.5mm entrance aperture, and matched pair of 1.8µm wide slits. Use from 700nm to 1.8µm wavelength.	PH00424
NS2-Ge/9/5-STD	NanoScan2 Ge Detector 9mm Aperture 5.0µm slits. High-resolution head featuring Germanium detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 700nm to 1.8µm wavelength.	PH00425
NS2-Ge/9/25-STD	NanoScan2 Ge Detector 9mm Aperture 25µm slits. High-resolution head featuring Germanium detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 25µm wide slits. Use from 700nm to 1.8µm wavelength.	PH00426
NS2-Pyro/9/5-STD	NanoScan2 Pyro Detector 9mm Aperture 5.0µm slits. High-resolution head featuring pyroelectric detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 190nm to >100µm wavelength	PH00427
NS2-Pyro/9/25-STD	NanoScan2 Pyro Detector 9mm Aperture 25.0µm slits. High-resolution head featuring pyroelectric detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 190nm to >100µm wavelength	PH00428
NS2-Si/3.5/1.8-PRO	NanoScan2 Silicon Detector 3.5mm aperture 1.8µm slits. High-resolution head featuring Silicon detector, 63.5mm diameter head with rotation mount, 3.5mm entrance aperture, and matched pair of 1.8µm wide slits. Use from 190nm to wavelengths <1µm. Not for 1.06µm wavelength. Software includes ActiveX automation feature.	PH00429
NS2-Si/9/5-PRO	NanoScan2 Si Detector 9mm aperture 5µm slits. High-resolution head featuring Si detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 190nm to wavelengths <1µm. Not for 1.06µm wavelength. Software includes ActiveX automation feature	PH00430
NS2-Si/9/25-PRO	NanoScan2 Si Detector 9mm aperture 25µm slits. High-resolution head featuring Si detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 25µm wide slits. Use from 190nm to wavelengths <1µm. Not for 1.06µm wavelength. Software includes ActiveX automation feature	PH00431
NS2-Ge/3.5/1.8-PRO	NanoScan2 Ge Detector 3.5mm aperture 1.8µm slits. High-resolution head featuring Germanium detector, 63.5mm diameter head with rotation mount, 3.5mm entrance aperture, and matched pair of 1.8µm wide slits. Use from 700nm to 1.8µm wavelength. Software includes ActiveX automation feature	PH00432
NS2-Ge/9/5-PRO	NanoScan2 Ge Detector 9mm Aperture 5µm slits. High-resolution head featuring Germanium detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 700nm to 1.8µm wavelength. Software includes ActiveX automation feature	PH00433
NS2-Ge/9/25-PRO	NanoScan2 Ge Detector 9mm Aperture 25µm slits. High-resolution head featuring Germanium detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 25µm wide slits. Use from 700nm to 1.8µm wavelength. Software includes ActiveX automation feature	PH00434
NS2-Pyro/9/5-PRO	NanoScan2 Pyro Detector 9mm Aperture 5.0µm slits. High-resolution head featuring pyroelectric detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 190nm to >100µm wavelength. Software includes ActiveX automation feature	PH00435
NS2-Pyro/9/25-PRO	NanoScan2 Pyro Detector 9mm Aperture 25.0µm slits. High-resolution head featuring pyroelectric detector, 63.5mm diameter head with rotation mount, 9mm entrance aperture, and matched pair of 5µm wide slits. Use from 190nm to >100µm wavelength. Software includes ActiveX automation feature	PH00436
Software Upgrades		
NSv2 STD to NSv2 PRO Upgrade	Upgrade NanoScan v2 Standard version software to the PRO version. This upgrade opens the NanoScan automation feature for those users wanting to integrate or develop their own interface using Visual Basic for Applications to embed into such applications as LabView. Return scanhead to factory.	PH00417
NSv1 to NSv2 STD Upgrade	For those NanoScan users with pre v2 software (approx. before July 2012) they can upgrade their hardware to v2 STD capability and can run the new software. Automation capability is not available in v2 STD. Once upgraded the legacy software will run but the automation feature will be disabled in v2	PH00418
NSv1 to NSv2 PRO Upgrade	For those NanoScan users with pre v2 software (approx. before July 2012) they can upgrade their hardware to v2 PRO capability and can run the new software. Automation capability is included in v2 PRO. Once upgraded the legacy software will run including the automation capability in v2	PH00419
Legacy Software	Purchase the legacy V1.47 NanoScan software with licence and operations manual to –PRO scanheads to use the older software. (return scanhead to factory)	PH00420
Accessories		
RAL-FXT	Rayleigh fixture for manual M2	PH00073
COL-FXT 250	250 mm FL collimation fixture	PH00070
COL-FXT 500	500 mm FL collimation fixture	PH00227



Pyroelectric / 9mm / 5mm

Responsivity: Detector conversion constant, incident photons to a current.

Detector: Responsivity varies with wavelength. Detects between 700-1800nm. Peak responsivity is 0.7 amps/watt at 1550nm. **Detector to detector responsivity variation can be as great as ±20%.**

Power: Power in the measured laser beam. Assumes a round beam diameter. An elliptic beam can be approximated by using the maximum width dimension and assuming all the energy is in a beam of this diameter. For extremely elliptic beams (ratio >4:1) contact the factory.

Beam Diameter: Circular laser spot being measured by a narrow slit. Clip level method.

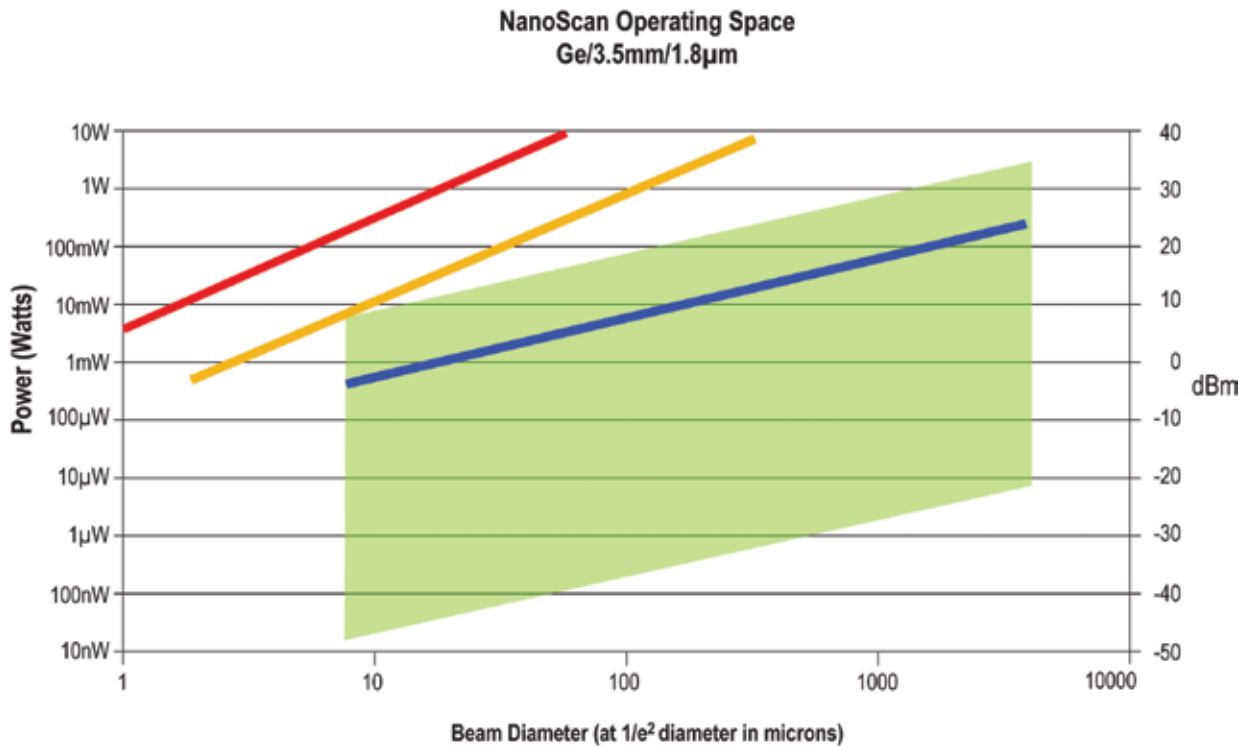
Pulsed Operation (—): Upper limit of the operating space for pulsed laser measurements.

Black Coating Removed (—): Slits are blackened to reduce back reflections; blackening begins to vaporize near this line. Slits in pyro detectors are not blackened.

Slit Damage (—): Power density (watts/cm²) where one can begin to cut the slits. Refer to Photon's Aperture Damage due to High Incident Power document.

Left Boundary: Smallest beam size limited to 4-5 times the slit width. Some models have another limit due to electrical bandwidth.

Right Boundary: Instrument entrance aperture. The largest beam width (1/e²) will be the aperture divided by 1.2-1.4.



Germanium Detector

Responsivity: Detector conversion constant, incident photons to a current.

Detector: Responsivity varies with wavelength. Detects between 700-1800nm. Peak responsivity is 0.7 amps/watt at 1550nm. Detector to detector responsivity variation can be as great as $\pm 20\%$.

Power: Power in the measured laser beam. Assumes a round beam diameter. An elliptic beam can be approximated by using the maximum width dimension and assuming all the energy is in a beam of this diameter. For extremely elliptic beams (ratio >4:1) contact the factory.

Beam Diameter: Circular laser spot being measured by a narrow slit. Clip level method.

Pulsed Operation (): Upper limit of the operating space for pulsed laser measurements.

Black Coating Removed (): Slits are blackened to reduce back reflections; blackening begins to vaporize near this line. Slits in pyro detectors are not blackened.

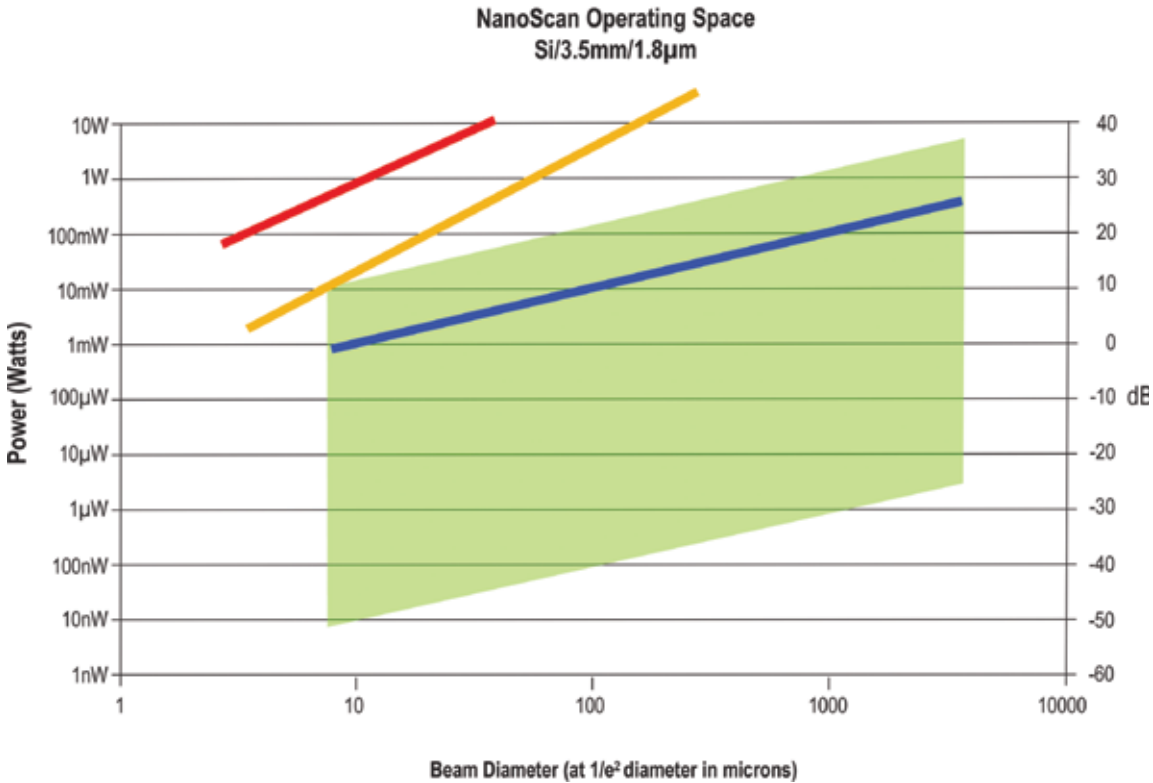
Slit Damage (): Power density (watts/cm²) where one can begin to cut the slits. Refer to Photon's Aperture Damage due to High Incident Power document.

Left Boundary: Smallest beam size limited to 4-5 times the slit width. Some models have another limit due to electrical bandwidth.

Right Boundary: Instrument entrance aperture. The largest beam width (1/e²) will be the aperture divided by 1.2-1.4.

Typical NanoScan Operating Space Charts

Operating range is at peak sensitivity of detector. Operating space is NOT absolute. THESE CHARTS TO BE USED AS A GUIDE ONLY.



Silicon Detector

Silicon Detector: Responsivity varies with wavelength. Detects between 190-950nm. Peak responsivity is 0.4 amps/watt at 850nm. Detector to detector responsivity variation can be as great as $\pm 20\%$.

Power: Power in the measured laser beam. Assumes a round beam diameter. An elliptic beam can be approximated by using the maximum width dimension and assuming all the energy is in a beam of this diameter. For extremely elliptic beams (ratio $>4:1$) contact the factory.

Pulsed Operation (————): Upper limit of the operating space for pulsed laser measurements.

Black Coating Removed (————): Slits are blackened to reduce back reflections; blackening begins to vaporize near this line. Slits in pyrodetectors are not blackened.

Slit Damage (————): where one can begin to cut the slits. Refer to Photon's Damage Threshold with High Power Laser Measurements document.

Left Boundary: Smallest beam size limited to 4-5 times the slit width. Some models have another limit due to electrical bandwidth.

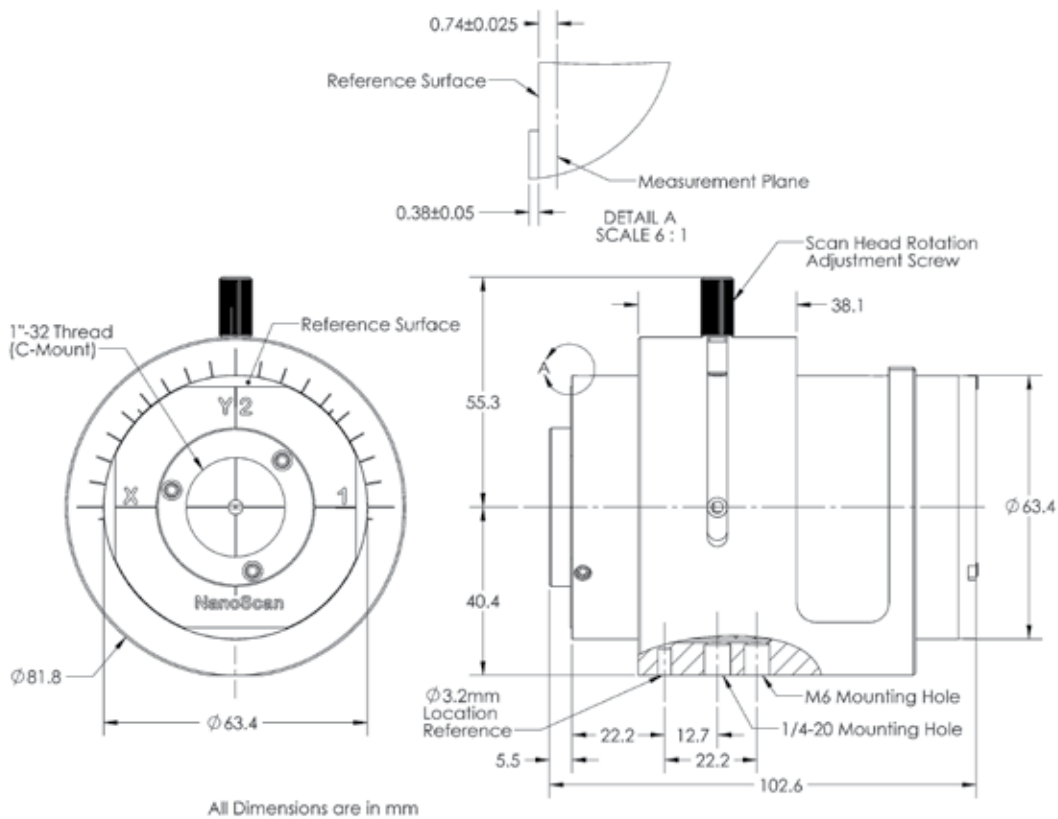
Right Boundary: Instrument entrance aperture. The largest beam width (1/e²) will be the aperture divided by 1.2-1.4.

Specifications

Model	General Specification
Bus interface	USB 2.0
Signal digitization	16bit
Maximum digitization clock	21.4MHz
Maximum update rate	20Hz
Data transfer	Bulk Transfer Mode
On-board memory	64MB mDDR SDRAM
Weight	434g (15.3 ounces)
Operating temperature	0...50°C
Humidity	90%, non-condensing
Scanhead Dimensions	4.04"(10.26mm) L X 2.5"(6.35cm) Ø
Power	USB 2.0 Bus Powered
CPU Clock	300MHz
Memory Clock	264MHz
Scanning Motor	Brushed DC, 4W max

Mechanical Dimensions

NanoScan2 Standard Scanhead: NS2-Si, NS2-Ge and NS2-Pyro



NanoScan 2 Acquisition and Analysis Software

Use the Software specification from the existing NanoScan 2 data sheet

*Feature		NanoScan Standard	NanoScan Professional (all features in Standard plus)
Controls			
Source	ScanHead Select, Gain, Filter, Sampling Resolution, AutoFind, Rotation Frequency, Record Mode	•	
Capture	Averaging, Rotation, Magnification, CW or Pulse Modes, Divergence, Gaussian Fit, Reference Position, Recompute	•	
Regions of Interest (ROI)	Single or Multiple, Automatic or Manual, Colors	•	
Profiles	Vertical Scale (1', 10', 100'), Logarithmic Scale, Z & PAN (Automatic or Manual)	•	
Computation: ISO 13694, ISO 11146	D _{slit} (13.5%, 50% 2 User Selectable Clip Levels), D ₄₀ , Width ratios, Centroid Position, Peak Position, Centroid Separation, Peak Separation, Irradiance, Gaussian Fit, Ellipticity, Divergence, Total Power, Pulse Frequency, % power	•	
	Continuous, Rolling, Finite	•	
Pointing	Centroid or Peak, Accumulate Mode, Beam Indicator, Graph Center, Colors	•	
2D/3D	2D or 3D Mode, Linear or Logarithmic Scale, Resolution, Fill Contours, Solid Surface, or Wireframe, Clip Level Colors	•	
Charts	Chart Select, Parameter Select, Aperture Select, Update Rate, Start and Clear	•	
Logging	File Path/Name, Delimiter, Update Rate	•	
M ²	Rail Setup: Com Port and Length, Connect/Disconnect, Rail Control	•	
Views			
Profiles	Displays Beam Profiles for each axis, with optional Gaussian Overlays	•	
Results	Displays Values and Statistics for Selected results	•	
Pointing	Displays the XY position of the Centroid or Peak for each ROI, with optional overlays and Accumulate Mode	•	
Charts	Displays Time Charts for User-selected results	•	
2D/3D	Displays pseudo 2D/3D Beam Profile	•	
M ² Wizard	An interactive procedure for measuring M ² by the Rayleigh Method	•	
File Saving			
NanoScan Data Files		•	
Text Files		•	
Data Logging			
Log to File		•	
Reports			
NanoScan Report		•	
Automation Interface			
ActiveX Automation Server			•
Minimum System Requirements			
PC computer running windows 7 (32/64) Laptop or Desktop ¹			
A dual core processor CPU, 2GHz or better			
2GB of RAM ²			
1-USB 2.0 port available			
At least 250MB of free HDD space			
1400 x 900 display resolution or better			
Graphics card w/hardware accelerator			
DVD-ROM drive			
Microsoft compatible pointing devices(e.g., mouse, trackball, etc)			

*Download the NanoScan Acquisition and Analysis Software Manual for a complete description of all Software Features

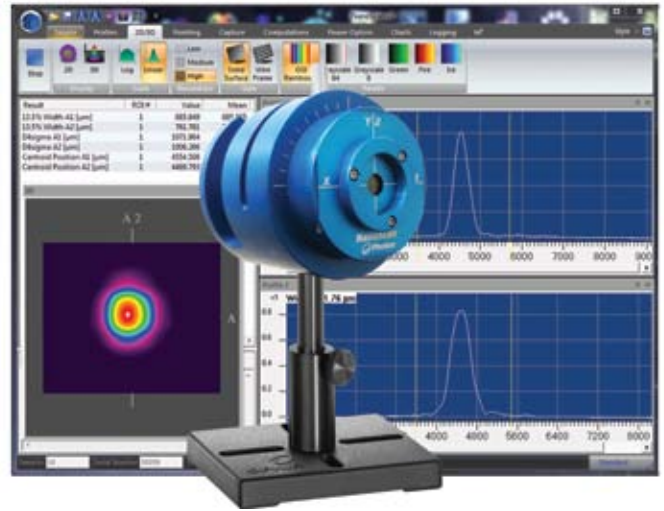
1. A business/professional version of windows is recommended. The NanoScan v2 software has not been tested with home versions of Windows. Both 64-bit and 32-bit versions of Windows 7 are supported. NanoScan v2 is no longer tested on Windows XP 32-bit operating systems.
2. The computer memory (RAM) will affect the performance of the software in the Data Recorder.

3.3.1 NanoScan 2

Scanning Slit Beam Profiler For High Accuracy Dimensional Measurement

NanoScan 2 combines the convenience and portability of direct USB connectivity with the speed, accuracy, and dynamic range that users have come to expect from the Photon NanoScan slit based profilers. The NanoScan 2 is available with a silicon, germanium or pyroelectric detector, which allows it to profile lasers of any wavelength from UV to far infrared, out to 100 μ m and beyond. With the new NanoScan 2 software package, the user can configure the display interface however it is desired; displaying those results of most interest on one easy-to-read screen, or on multiple screens.

The NanoScan slit profiler is the most versatile laser beam profiling instrument available today: providing instantaneous feedback of beam parameters for CW and kilohertz pulsed lasers, with measurement update rates to 20Hz. The natural attenuation provided by the slit allows the measurement of many beams with little or no additional attenuation. The high dynamic range makes it possible to measure beams while adjustments to focus are made without having to adjust the profiler. Just aim the laser into the aperture and the system does the rest!



Capabilities

NanoScan 2 is a PC-based instrument for the measurement and analysis of laser beam spatial irradiance profiles in accordance with the ISO standard 11146. The scan heads also measure power in accordance with ISO 13694.

NanoScan uses the scanning slit, one of the ISO Standard scanning aperture techniques. It can measure beam sizes from microns to centimeters at beam powers from microwatts to over kilowatts, often without attenuation. Detector options allow measurement at wavelengths from the ultraviolet to the infrared.

The NanoScan2 digital controller has 16-bit digitization of the signal for enhanced dynamic range up to 35dB power optical. With the accuracy and stability of the beam profile measurement you can measure beam size and beam pointing with a 3-sigma precision of several hundred nanometers. The software controllable scan speed and a "peak-connect" algorithm allows the measurement of pulsed and pulse width modulated lasers with frequencies of 10kHz and higher*. The NanoScan is also able to measure up to 16 beams, or regions of interest, in the aperture simultaneously.

Benefits

- Absolute measurement accuracy is guaranteed by NIST traceable calibration of every NanoScan
- Measure any wavelength from UV to very far infrared (190nm to >100 μ m)
- Instantaneous real time display of results; beam found in less than 300ms and updated at up to 20Hz
- Waist location can be determined to within $\pm 25\mu$ m due to the well-defined Z-axis datum plane of the NanoScan
- Measure pulsed and CW lasers
- For pulsed beams the pulse rate is measured and reported
- From as small as 7 μ m beams, can be measured directly with guaranteed accuracy and precision
- Additional high signal to noise ratio can be achieved with averaging
- Z-axis caustic measurements are available with built-in mechanical linear stage control
- M2 propagation ratio values available with simple M2 Wizard included with the software.
- Any beam result can be charted and monitored over time
- Power levels can be monitored along with spatial measurements to determine if losses are introduced by beam adjustments
- Log results to text files for independent analysis
- Automate the system using optional ActiveX Automation commands, available with the PRO version software and scan heads
Samples of automation programs included for Excel,VBA, LabView and Visual Basic.net

*The minimum frequency is a function of the beam size and the scan speed. This is a simple arithmetic relationship; there must be a sufficient number of pulses during the time that the slits sweep through the beam to generate a meaningful profile. Please refer to Photon's Application Note, Measuring Pulsed Beams with a Slit-Based Profiler.